MSKSEMI















ESD

TVS

TSS

MOV

GDT

PLED

Brodnet data speet

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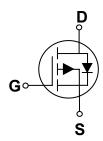








SOT-23-3L



Features

- $30V_{\tau} 3.0A, RDS(ON) = 75m\Omega@VGS = -10V$
- Fast switching
- Green Device Available
- Suit for -4 5V Gate Drive Applications

Applications

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

BVDSS	RDSON	ID
-30V	75m Ω	-3.0A

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _D S	Drain-Source Voltage	-30	V
Vgs	Gate-Source Voltage	±20	V
I-	Drain Current – Continuous (T _A =25°C)	-3.0	А
lo	Drain Current – Continuous (T _A =70°C)	- 2.0	А
Ірм	Drain Current – Pulsed¹	- 12.0	Α
D _n	Power Dissipation (T _A =25°C)	1.56	W
Po	Power Dissipation – Derate above 25℃	0.012	W/°C
Тѕтс	Storage Temperature Range	-55 to 150	℃
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	°C/W







Off Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
BVDSS	Orain-Source Breakdown Voltage V _{GS} =0V , I _D = - 250uA		-30			V
△ BVDSS/ △ TJ	BV _{DSS} Temperature Coefficient	Coefficient Reference to 25°C , ID=-1mA		-0.02		V/°C
	Dunin Course Legland Current	V _{DS} =-27V , V _{GS} =0V , T _J =25°C			- 1	uA
I _{DSS} Drain-Source Leakage Current		V _{DS} =-24V , V _{GS} =0V , T _J =125°C			- 10	uA
Igss	Gate-Source Leakage Current	V _{GS} = ±20V , V _{DS} =0V			±100	nA

On Characteristics

Brazaus	Chatia Basia Casasa Ca Basiatana	V _{GS} =-10V , I _D =-3A		75	115	mΩ
RDS(ON) Static Drain-Source On-Resistance		Vgs=-4.5V , Ip=-2A		110	145	mΩ
V _{GS(th)}	Gate Threshold Voltage			- 1.6	-2.5	V
△ VGS(th)	V _{GS(th)} Temperature Coefficient	Vgs=Vds , Id =-250uA		-2.8		mV/°C
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-1A		3		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2, 3}		 2.5	
Qgs	Gate-Source Charge ^{2, 3}	V _{DS} =-24V , V _{GS} =-4.5V , I _D =-2A	 0.1	 nC
Qgd	Gate-Drain Charge ^{2, 3}		 1.8	
T _{d(on)}	Turn-On Delay Time ^{2, 3}		 6.1	
Tr	Rise Time ^{2,3}	V _{DD} =-15V , V _G s=-10V , R _G =6 Ω	 8.7	
Td(off)	Turn-Off Delay Time ^{2, 3}	Ip=-1A	 33.2	 ns
Tf	Fall Time ^{2, 3}	ID- 177	 3.7	
Ciss	Input Capacitance		 226	
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , F=1MHz	 39	 pF
Crss	Reverse Transfer Capacitance		 29	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions		Тур.	Max.	Unit
ls	Continuous Source Current	\/\/\/\/\/\/			-3.0	Α
Іѕм	Pulsed Source Current	V _G =V _D =0V , Force Current			- 6.0	Α
Vsp	Diode Forward Voltage	Vgs=0V , Is=-1A , TJ=25°C			- 1.2	V

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
 The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
- 3. Essentially independent of operating temperature.



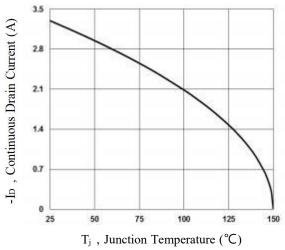


Fig.1 Continuous Drain Current vs. Tc

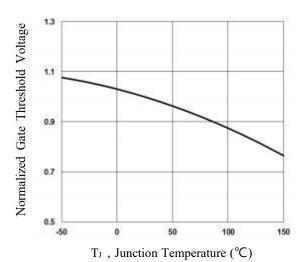


Fig. 3 Normalized V_{th} vs. T_J

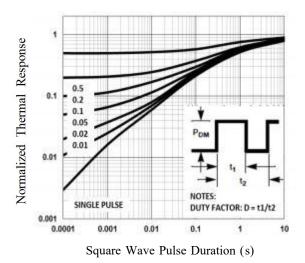


Fig. 5 Normalized Transient Impedance

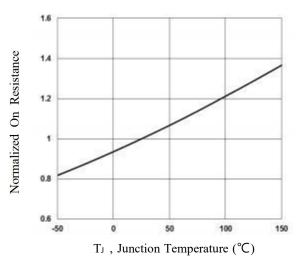


Fig. 2 Normalized RDSON vs. TJ

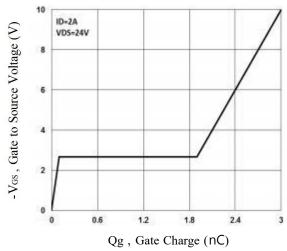


Fig. 4 Gate Charge Waveform

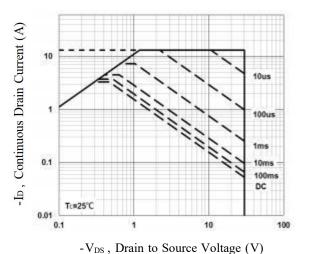
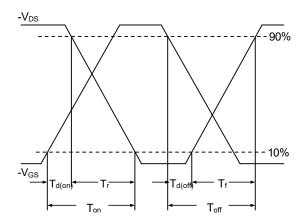


Fig.6 Maximum Safe Operation Area





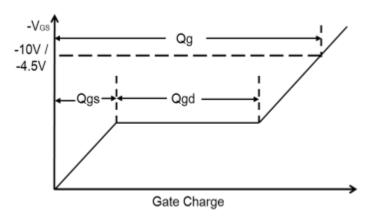
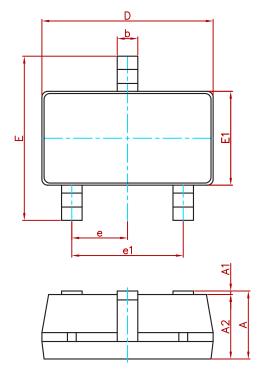


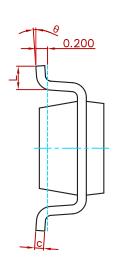
Fig. 7 Switching Time Waveform

Fig. 8 Gate Charge Waveform

Semiconductor

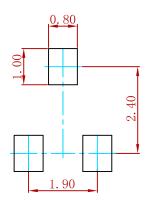
PACKAGE MECHANICAL DATA





Symbol	Dimensions In Millimeters		Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950(0.950(BSC)		(BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AO3409	SOT-23-3L	3000



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